SN5475, SN5477, SN54LS75, SN54LS77, SN7475, SN74LS75 4-BIT BISTABLE LATCHES

MARCH 1974 - REVISED MARCH 1988

FUNCTION TABLE (each latch)

INP	UTS	OUTPUTS				
D	С	α	<u> </u>			
L	H	L	Н			
н	н	Н	L			
Х	L	\mathbf{c}_0	$\overline{\mathbf{o}}_0$			

H = high level, L = low level, X = irrelevant

 Q_0 = the level of Q before the high-to-low transition of G

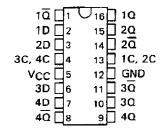
description

These latches are ideally suited for use as temporary storage for binary information between processing units and input/output or indicator units. Information present at a data (D) input is transferred to the Q output when the enable (C) is high and the Q output will follow the data input as long as the enable remains high. When the enable goes low, the information (that was present at the data input at the time the transition occurred) is retained at the Q output until the enable is permitted to go high.

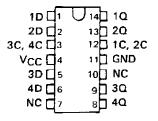
The '75 and 'LS75 feature complementary Q and \overline{Q} outputs from a 4-bit latch, and are available in various 16-pin packages. For higher component density applications, the '77 and 'LS77 4-bit latches are available in 14-pin flat packages.

These circuits are completely compatible with all popular TTL families. All inputs are diode-clamped to minimize transmission-line effects and simplify system design. Series 54 and 54LS devices are characterized for operation over the full military temperature range of $-55\,^{\circ}\mathrm{C}$ to $125\,^{\circ}\mathrm{C}$; Series 74, and 74LS devices are characterized for operation from $0\,^{\circ}\mathrm{C}$ to $70\,^{\circ}\mathrm{C}$.

SN5475, SN54LS75 . . . J OR W PACKAGE SN7475 . . . N PACKAGE SN74LS75 . . . D OR N PACKAGE (TOP VIEW)

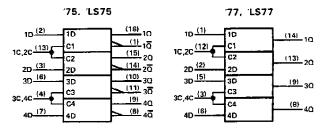


SN5477, SN54LS77 . . . W PACKAGE (TOP VIEW)



NC - No internal connection

logic symbols[†]



[†]These symbols are in accordance with ANSI/IEEE Std 91-1984 and IEC Publication 617-12.

absolute maximum ratings over operating free-air temperature range (unless otherwise noted)

Supply voltage, VCC (See Note 1)		7 V
Input voltage: '75, '77	.,	5.5 V
'LS75, 'LS77		7 V
Interemitter voltage (see Note 2)		5.5 V
Operating free-air temperature range:	SN54'	-55°C to 125°C
	SN74'	0° C to 70°C
Storage temperature range		-65°C to 150°C

NOTES: 1. Voltage values are with respect to network ground terminal.

2. This is the voltage between two emitters of a multiple-emitter input transistor and is not applicable to the 'LS75 and 'LS77.

logic diagrams (each latch) (positive logic) 75, 77 ā To ('75)Other Latch ENABLE С DATA 'LS75 'LS77 DATA -ā DATA -TO TO Q OTHER OTHER LATCH LATCH ENABLE ENABLE С schematics of inputs and outputs 75, 77 'LS75, 'LS77 EQUIVALENT OF EACH INPUT EQUIVALENT OF EACH INPUT Vccvcc. \$Req Reg INPUT-INPUT Data: $R_{eq} = 2 k\Omega$ NOM Enable: $R_{eq} = 1 k\Omega$ NOM Data: $R_{eq} = 17 \text{ k}\Omega$ Enable: $R_{eq} = 4.2 \text{ k}\Omega$ **′**75, ′77 'LS75, 'LS77 TYPICAL OF ALL OUTPUTS TYPICAL OF ALL OUTPUTS ≹ 120 Ω ·Vcc 130 Ω NOM NOM -OUTPUT OUTPUT



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recommended operating conditions

	SN5	SN5475, SN5477			SN7475		
	MIN	NOM	MAX	MIN	NOM	MAX	UNIT
Supply voltage, VCC	4.5	5	5.5	4.75	5	5.25	V
High-level output current, IOH			-400		_	-400	μА
Low-level output current, IOL			16			16	mΑ
Width of enabling pulse, tw	20			20			ns
Setup time, t _{su}	20			20			п\$
Hold time, th	5			5			ПБ
Operating free-air temperature, TA	-55		125	0		70	³.C

electrical characteristics over recommended operating free-air temperature range (unless otherwise noted)

	PARAMETER		TEST CO	ONDITIONS†	MIN	TYP‡	MAX	UNIT
VIH	High-level input voltage				2		-	٧
VIL	Low-level input voltage				1		0.8	V
VłK	Input clamp voltage		V _{CC} = MIN,	I _J = -12 mA			-1.5	V
νон	VAH High-level output voltage		V _{CC} = MIN, V _{IL} = 0.8 V,	V _{1H} = 2 V, 1 _{OH} = -400 μA	2,4	3.4		٧
VOL	DL Low-level output voltage		V _{CC} = MIN, V _{IL} = 0.8 V,	V _{IH} = 2 V, I _{OL} = 16 mA		0,2	0.4	٧
. 1	Input current at maximum input voltage	Input current at maximum input voltage		V ₁ = 5.5 V			1	mA
ЧН	High-level input current	D input C input	V _{CC} = MAX,	V ₁ = 2.4 V			80 160	μA
1	Low-level input current	D input	V _{CC} = MAX,	V ₁ = 0.4 V			-3.2	mA
L	Low-level imparcullent	C input	VCC = MA∧,	V = 0.4 V			-6.4	mA
loo	Short-circuit output current §		V _{CC} = MAX	SN54'	-20		-57	- A
los _	Onor-encur output consists		ACC - MAY	SN74'	-18		-57	mA
1	Sur-la sur-4		V _{CC} = MAX,	SN54'		32	46	
'cc	Supply current		See Note 3	SN74'		32	53	mA

For conditions shown as MIN or MAX, use the appropriate value specified under recommended operating conditions.

switching characteristics, $V_{CC} = 5 \text{ V}$, $T_A = 25^{\circ}\text{C}$

PARAMETER	FROM (INPUT)	TO (OUTPUT)	TEST CONDITIONS	MIN	TYP	MAX	UNIT
tPLH	ם	<u> </u>	C 15 oF		16	30	
†PHL					14	25	ns
tPLH¶	D	ā			24	40	
t₽HL¶	_ - -		7	15	ns		
tPLH .	С	Q	R _L = 400 Ω, See Figure 1		16	30	-
[†] PHL	·	_	Geer igure i		7	15	ns
tPLH¶	С	ā			16	30	-
tPHL¶		_	7	15	ηs		

 $t_{PLH} \equiv propagation delay time, low-to-high-level output$

[‡]All typical values are at V_{CC} = 5 V, T_A = 25°C.

§ Not more than one output should be shorted at a time.

NOTE 3: I_{CC} is tested with all inputs grounded and all outputs open.

 $t_{PHL} \approx propagation delay time, high-to-low-level output$

 $[\]P$ These parameters are not applicable for the SN5477.

SN54LS75, SN54LS77, SN74LS75 4-BIT BISTABLE LATCHES

recommended operating conditions

		SN54LS75 SN54LS77			SN74LS75		
	MIN	NOM	MAX	MIN	MOM	MAX	
Supply voltage, V _{CC}	4.5	5	5.5	4.75	5	5,25	٧
High-level output current, IOH			-400			-400	μА
Low-level output current, IOL		_	4			8	mA
Width of enabling pulse, tw	20			20			ns
Setup time, t _{Su}	20			20			ns
Hold time, th	5			5			ns
Operating free-air temperature, TA	–55		125	0		70	°C

electrical characteristics over recommended operating free-air temperature range (unless otherwise noted)

PARAMETER		TES	TEST CONDITIONS†		SN54LS75 SN54LS77			\$N74L\$75			UNIT
		-				TYP‡	MAX	MIN	TYP‡	MAX]
VIН	High-level input voltage				2			2			V
VIL	Low-level input voltage						0.7			0.8	V
VIK	Input clamp voltage	V _{CC} = MIN, I _I = -18 mA				-1.5	-		-1.5	٧	
Vон	High-level output voltage	$V_{CC} = MIN$, $V_{IH} = 2 V$, $V_{IL} = V_{IL} max$, $I_{OH} = -400 \mu A$			2.5	3.5		2.7	3.5		V
VOL	Low-level output voltage	VCC = MIN.	V _{IH} = 2 V,	I _{OL} = 4 mA		0.25	0.4		0.25	0.4	V
VOL	Cow-lever output vortage	VIL = VIL max		IOL = B mA					0.35	0.5	
1լ	Input current at	VCC = MAX.	V ₁ = 7 V	D input			0.1			0.1	_^
''	maximum input voltage	TOU - WIAA.	41-14	Cinput			0.4		<u>-</u>	0.4	mA
Lan	High-level input current	V _{CC} = MAX,	V ₁ ≈ 2.7 V	D input		20			20		
ΉΗ	angin-level input current	ACC - MINY	2.7 0	Cinput			80			80	μА
I _{IL}	Low-level input current	Vcc - MAX,	V _I = 0.4 V	D input			-0.4		•	-0.4	mΑ
יונ	Low-level input current VCC - MAX, VI - 0.		VI - 0.4 V	Cinput			-1.6			-1.6	IDA
los	Short-circuit output current 8	V _{CC} = MAX			-20		-100	-20		-100	mA
Icc	Supply current	V _{CC} = MAX,	See Note 2	'LS75		6.3	12		6.3	12	mΑ
	Coppie contain	ACC - MAY' 266 Note 5		'LS77		6.9	13				''' ^

[†] For conditions shown as MIN or MAX, use the appropriate value specified under recommended operating conditions.

switching characteristics, VCC = 5 V, TA = 25 $^{\circ}$ C

PARAMETER ¶	FROM	то	TEST COMPLETIONS		'LS75			'LS77		
FANAMETER.	(INPUT)	(QUTPUT)	TEST CONDITIONS	MIN	TYP	MAX	MIN	TYP	MAX	UNIT
^T PLH	D	0			15 27	11	19			
tPHL tpHL			9	17		9	17	กร		
^t PLH	D	O	Ω C_L = 15 pF, R_L - 2 k Ω , See Figure 1		12	20				T
tPHL]				7	15				ns
^t PLH	С	0			15	27		10	18	ns
tPHL		Ġ.			14	25		10	18	lis
tPLH	С	ō			16	30				ns
tPHL		<u> </u>			7	15				''\$

f tplH = propagation delay time, (ow-to-high-leve) output

tpLH = propagation delay time, high-to-low-level output



 $[\]ddagger$ All typical values are at V_{CC} = 5 V, T_A = 25°C. Not more than one output should be shorted at a time, and duration of the short-circuit should not exceed one second

NOTE 2: ICC is tested with all inputs grounded and all outputs open.

Vol

PARAMETER MEASUREMENT INFORMATION switching characteristics † INPUTS OUTPUTS V_{CC} \$_{RL} **PULSE** D Q GENERATOR A (See Note A) (See Note C) CL = 15 pF С (See Note B) ā PULSE GENERATOR B C_L = 15 pF (See Note A) (See Note B) **TEST CIRCUIT** - ≤ 10 ns - ≤ 10 ns 90% 90% D INPUT 10% 10% 0 V tsu th 3 V 90% CINPUT 90% **ISee** 10% Note D) 500 ns 500 ns -tPLH TPHL tpHI ۷он OUTPUT Q VOL tPLH - ∨он IPLH

[†]Complementary Q outputs are on the '75 and 'LS75 only.

OUTPUT \alpha

NOTES: A. The pulse generators have the following characteristics: Z_{Out} ≈ 50 Ω; for pulse generator A, PRR ≤ 500 kHz; for pulse generator B, PRR ≤ 1 MHz. Positions of D and C input pulses are varied with respect to each other to verify setup times.

VOLTAGE WAVEFORMS

- B. C_L includes probe and jig capacitance.
- C. All diodes are 1N3064 or equivalent.
- D. When measuring propagation delay times from the D input, the corresponding C input must be held high.
- E. For '75 and '77, V_{ref} = 1.5 V; for 'LS75 and 'LS77, V_{ref} = 1.3 V.

- tPHL

FIGURE 1



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